

# Search Notes



Application/Control No.

10/623,414

Examiner

Henry K. Choe

Applicant(s)/Patent under Reexamination

DEEM ET AL.

Art Unit

2817

## SEARCHED

Class	Subclass	Date	Examiner
330	151	12/14/05 H.C.	
"	149	"	"
375	297	"	"
455	63	12/15/05 "	
Updated search		9/4/05 H.C.	

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
True search (East)	3/15/05 H.C.	
NPL (IEEE)	"	"